



# 74VHCT138A 3-to-8 Decoder/Demultiplexer

#### **Features**

- High Speed:  $t_{PD} = 7.6$ ns (Typ.) at  $V_{CC} = 5V$
- Low power dissipation:  $I_{CC} = 4\mu A$  (Max.) at  $T_A = 25^{\circ}C$
- Power down protection is provided on all inputs and outputs
- Pin and function compatible with 74HCT138

### **General Description**

The VHCT138A is an advanced high speed CMOS 3-to-8 DECODER fabricated with silicon gate CMOS technology. It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

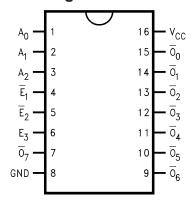
When the device is enabled, 3 Binary Select inputs  $(\underline{A}_0,\ \underline{A}_1\ \text{and}\ \underline{A}_2)$  determine which one of the outputs  $(\overline{O}_0-\overline{O}_7)$  will go LOW. When enable input  $E_3$  is held LOW or either  $\overline{E}_1$  or  $\overline{E}_2$  is held HIGH, decoding function is inhibited and all outputs go HIGH.  $E_3,\ \overline{E}_1\ \text{and}\ \overline{E}_2\ \text{inputs}$  are provided to ease cascade connection and for use as an address decoder for memory systems. Protection circuits ensure that 0V to 7V can be applied to the input pins without regard to the supply voltage and to the output pins with  $V_{CC}=0V$ . These circuits prevent device destruction due to mismatched supply and input/output voltages. This device can be used to interface 3V to 5V systems and two supply systems such as battery backup.

## **Ordering Information**

Order Number	Package Number	Package Description
74VHCT138AM	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
74VHCT138ASJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74VHCT138AMTC	MTC16	16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Surface mount packages are also available on Tape and Reel. Specify by appending the suffix letter "X" to the ordering number.

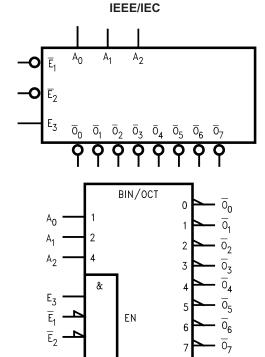
## **Connection Diagram**



# **Pin Description**

Pin Names	Description
A <sub>0</sub> -A <sub>2</sub>	Address Inputs
$\overline{E}_{1}\text{-}\overline{E}_{2}$	Enable Inputs
E <sub>3</sub>	Enable Input
$\overline{O}_0 - \overline{O}_7$	Outputs

# **Logic Symbols**



# **Truth Table**

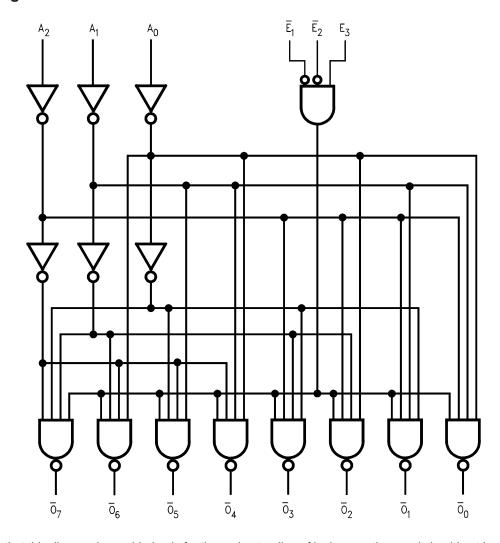
	Inputs								Out	puts			
E <sub>1</sub>	E <sub>2</sub>	E <sub>3</sub>	A <sub>0</sub>	<b>A</b> <sub>1</sub>	A <sub>2</sub>	$\overline{O}_0$	$\overline{O}_1$	$\overline{O}_2$	$\overline{O}_3$	$\overline{O}_4$	$\overline{O}_5$	$\overline{O}_6$	$\overline{O}_7$
Н	Х	Х	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н
Х	Н	Х	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н
Х	Х	L	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н
	•	•			•			•		•			
L	L	Н	L	L	L	L	Н	Н	Н	Н	Н	Н	Н
L	L	Н	Н	L	L	Н	L	Н	Н	Н	Н	Н	Н
L	L	Н	L	Н	L	Н	Н	L	Н	Н	Н	Н	Н
L	L	Н	Н	Н	L	Н	Н	Н	L	Н	Н	Н	Н
L	L	Н	L	L	Н	Н	Н	Н	Н	L	Н	Н	Н
L	L	Н	Н	L	Н	Н	Н	Н	Н	Н	L	Н	Н
L	L	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	L	Н
L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L

H = HIGH Voltage Level

L = LOW Voltage Level

X = Immaterial

# **Logic Diagram**



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

## **Absolute Maximum Ratings**

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Rating
V <sub>CC</sub>	Supply Voltage	-0.5V to +7.0V
V <sub>IN</sub>	DC Input Voltage	-0.5V to +7.0V
V <sub>OUT</sub>	DC Output Voltage	
	Note 1	–0.5V to 7.0V
	Note 2	-0.5V to V <sub>CC</sub> + 0.5V
I <sub>IK</sub>	Input Diode Current	–20mA
I <sub>OK</sub>	Output Diode Current <sup>(3)</sup>	±20mA
I <sub>OUT</sub>	DC Output Current	±25mA
I <sub>CC</sub>	DC V <sub>CC</sub> /GND Current	±75mA
T <sub>STG</sub>	Storage Temperature	−65°C to +150°C
T <sub>L</sub>	Lead Temperature (Soldering, 10 seconds)	260°C

# Recommended Operating Conditions<sup>(4)</sup>

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Rating
V <sub>CC</sub>	Supply Voltage	4.5V to +5.5V
V <sub>IN</sub>	Input Voltage	0V to +5.5V
V <sub>OUT</sub>	Output Voltage	
	Note 1	0V to 5.5V
	Note 2	0V to V <sub>CC</sub>
T <sub>OPR</sub>	Operating Temperature	–40°C to +85°C
t <sub>r</sub> , t <sub>f</sub>	Input Rise and Fall Time, V <sub>CC</sub> = 5.0V ±0.5V	0 ~ 20ns/V

#### Notes:

- 1.  $V_{CC} = 0V$ .
- 2. HIGH or LOW state. I<sub>OUT</sub> absolute maximum rating must be observed.
- 3.  $V_{OUT} < GND$ ,  $V_{OUT} > V_{CC}$  (Outputs Active).
- 4. Unused inputs must be held HIGH or LOW. They may not float.

## **DC Electrical Characteristics**

					T <sub>A</sub> = 25°C			T <sub>A</sub> = -40°C to +85°C		
Symbol	Parameter	$V_{CC}(V)$	Con	ditions	Min.	Тур.	Max.	Min.	Max.	Units
V <sub>IH</sub>	HIGH Level Input Voltage	4.5 – 5.5			2.0			2.0		V
V <sub>IL</sub>	LOW Level Input Voltage	4.5 – 5.5					0.8		0.8	V
V <sub>OH</sub>	OH HIGH Level Output			$I_{OH} = -50\mu A$	4.4	4.5		4.4		V
	Voltage		or V <sub>IL</sub>	$I_{OH} = -8mA$	3.94			3.80		
V <sub>OL</sub>	LOW Level Output	4.5		$I_{OL} = 50\mu A$		0.0	0.1		0.1	V
	Voltage		or V <sub>IL</sub>	$I_{OL} = 8mA$			0.36		0.44	
I <sub>IN</sub>	Input Leakage Current	0 – 5.5	V <sub>IN</sub> = 5.5V or GND				±0.1		±1.0	μΑ
I <sub>CC</sub>	Quiescent Supply Current	5.5	$V_{IN} = V_{CC}$ or GND				4.0		20.0	μA
I <sub>CCT</sub>	Maximum I <sub>CC</sub> /Input	5.5	$V_{IN} = 3.4V$ , All other inputs = $V_{CC}$ or GND				1.35		1.50	mA
I <sub>OFF</sub>	Output Leakage Current	0	V <sub>OUT</sub> = 5.5V				0.5		5.0	μΑ

## **AC Electrical Characteristics**

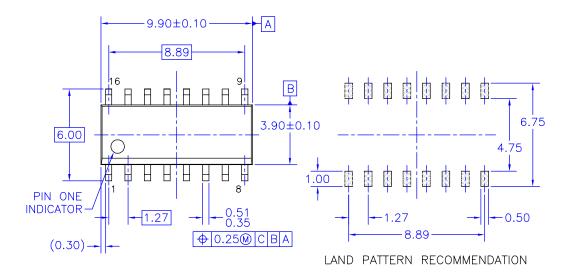
				T <sub>A</sub> = 25°C		T <sub>A</sub> = -40°C to +85°C			
Symbol	Parameter	V <sub>CC</sub> (V)	Conditions	Min.	Тур.	Max.	Min.	Max.	Units
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay,	5.0 ± 0.5	C <sub>L</sub> = 15pF		7.6	10.4	1.0	12.0	ns
	$A_n$ to $\overline{O}_n$		C <sub>L</sub> = 50pF		8.1	11.4	1.0	13.0	
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay,	5.0 ± 0.5	C <sub>L</sub> = 15pF		6.6	9.1	1.0	10.5	ns
	$E_3$ to $\overline{O}_n$		C <sub>L</sub> = 50pF		7.1	10.1	1.0	11.5	
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay,	5.0 ± 0.5	C <sub>L</sub> = 15pF		7.0	9.6	1.0	11.0	ns
	$\overline{\mathbb{E}}_1$ or $\overline{\mathbb{E}}_2$ to $\overline{\mathbb{O}}_n$		C <sub>L</sub> = 50pF		7.5	10.6	1.0	12.0	
C <sub>IN</sub>	Input Capacitance		V <sub>CC</sub> = Open		4	10		10	pF
C <sub>PD</sub>	Power Dissipation Capacitance		(5)		49				pF

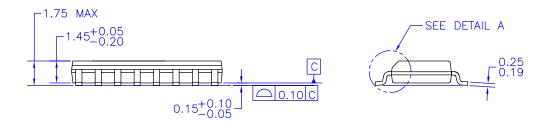
#### Note:

5.  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation:  $I_{CC}$  (Opr.) =  $C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$ 

# **Physical Dimensions**

Dimensions are in millimeters unless otherwise noted.





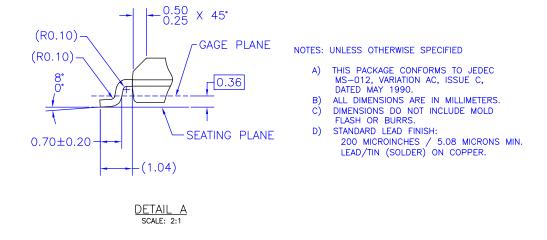
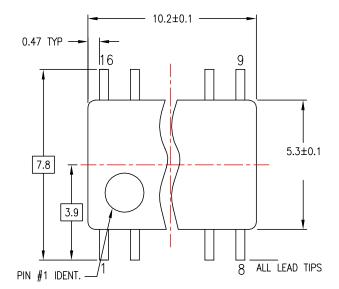


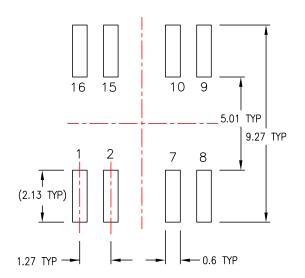
Figure 1. 16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M16A

M16AREVK

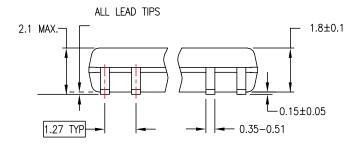
# Physical Dimensions (Continued)

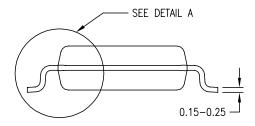
Dimensions are in millimeters unless otherwise noted.





#### LAND PATTERN RECOMMENDATION



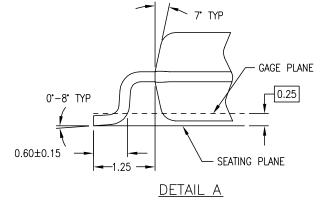


#### DIMENSIONS ARE IN MILLIMETERS

#### NOTES:

- A. CONFORMS TO EIAJ EDR-7320 REGISTRATION, ESTABLISHED IN DECEMBER, 1998.

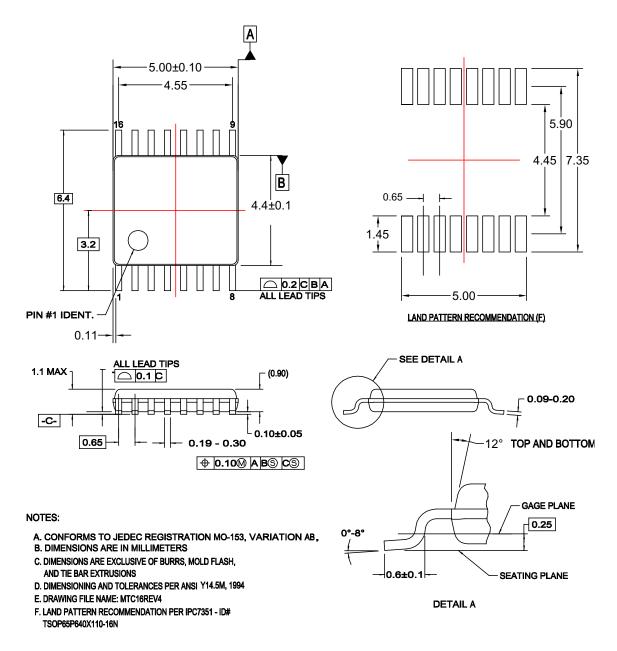
  B. DIMENSIONS ARE IN MILLIMETERS.
  C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.



M16DREVC

Figure 2. 16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide Package Number M16D

## Physical Dimensions (Continued) Dimensions are in millimeters unless otherwise noted.



MTC16rev4

Figure 3. 16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC16





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